

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
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			Examiner	Art Unit	Page 1 of 1
			Satyana Rayana R. Gudibande	1654	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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*	U	Jang, et al., 2002, FEBS letters, 521, 81-86.
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